

**Search Notes**

Application/Control No.

10/604,179

Examiner

Sun J. Lin

Applicant(s)/Patent under  
Reexamination

BERNSTEIN ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	6	1/6/2005	JSL
716	5	1/6/2005	JSL
716	4	1/6/2005	JSL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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EAST

[USPAT;US-  
PGPUB;UPO;JPO;DERWENT;IBM\_T  
DB]

1/6/2005

JSL

IEEE

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